Monolithic Kilopixel Silicon Microlens Arrays for Future Far-Infrared Observatories



Nicholas F Cothard^{*1}, Thomas Stevenson¹, Jennette Mateo¹, Felipe A. Colazo Petit¹, Nicholas Costen¹, Kevin Denis¹, NASA Postdoctoral Program Vorachai Kluengpho¹, Joanna Perido², Samelys Rodriguez¹, Ian Schrock¹, Frederick Wang¹, Jason Glenn¹ ¹NASA Goddard Space Flight Center, ²University of Colorado, Boulder, *nicholas.f.cothard@nasa.gov

Far-IR Monolithic Silicon Microlens Arrays

- The PRobe far-Infrared Mission for Astrophysics (PRIMA)
 - Observations of AGN feedback, interstellar medium physics in galaxies
 - Growth over cosmic time of stars, black holes, heavy elements, dust
 - Far-IR Kinetic Inductance Detector (KID) arrays [1,2,3]
 - Many arrays, each with thousands of detectors, $\lambda \sim 24 240 \,\mu m$
- Silicon monolithic microlens arrays for KID arrays
 - One microlens for each pixel
 - Concentrate optical power on to detector
- Fabrication methods developed:
 - Lithography-based microfabrication



Fabrication of Microlens Arrays

- Microlens array patterned with <u>grayscale lithography</u> • Calibrate dosage via exposure-contrast curve
- Plasma etching to transfer lens profile into silicon Control etch selectivity to achieve desired profile
- Successful demonstration of lens depths of ~ 150 μm
 - \circ Microlens pitches in the range 500 900 µm
 - Fresnel-style and full-sag lenses





• Detector-microlens array hybridization



Left: Kilo-pixel full-sag microlens array for $\lambda \sim 200 \ \mu m$.

SEM image of $\lambda \sim 25 \,\mu m$ Fresnel microlens array.



SEM image of $\lambda \sim 200 \ \mu m$ full-sag microlens array.

Hybridization of Microlens Arrays with Detector Arrays

- Successful demonstration of hybridization
 - Microlens-detector array bonding
 - \circ Precision alignment better than 10 μ m
 - Low-loss sub-micron thick epoxy layer
 - No voids or dust between dies
 - Quarter-wavelength Parylene-C AR coating



Surface Accuracy and Estimated Efficiency of Fabricated Arrays

- Successful demonstration of lens figure and surface roughness
 - Microlens surface figure deviations $\leq \pm 3\%$
 - Sub-micron surface roughness across lens
- Diffractive calculation to estimate expected encircled power
 - 85% efficiency for 105 µm absorber diameter
- Microlens arrays currently in use for PRIMA detector development [1]

- FLIR ($\lambda \sim 10 \ \mu$ m) and Zygo imaging used to verify:
 - Absence of inclusions between dies
 - Bond layer thickness uniformity
- Successful repeated cryogenic cycling tests • Robust bond and no ARC delamination



Above: Zygo optical profilometer measurement of hybridized array showing that the microlens die and

Above: Photograph of $\lambda \sim 25 \,\mu m$ hybridized microlens array. Below: FLIR photographs showing prototype hybridized arrays with (right) and without (left) inclusions.





detector die conform with a uniform bond thickness.



profiles. Solid lines indicate center wavelength (180 µm). Shaded regions indicate performance spanning this PIRMA band (135 – 240 μ m).

Conclusions and Next Steps

- Successful demonstration of monolithic microlens arrays
 - Fabricated prototypes exceed required performance
 - Hybridization method proven and robust
- Hybridized microlens arrays in use for PRIMA detector development [1,2,3]
 - \circ $\lambda \sim 30 \ \mu m$ hybrids used for sensitivity measurements
- Next steps:
 - Fabricate and hybridize PRIMA brassboard demonstration arrays
 - Extend to use for other projects (BEGINS [4]) Ο

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